P/3236-39

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

New York, New York

Group Art Unit:

Examiner:

Date:

June 20, 2006

2812

In re Patent Application of

Kenichi KOYANAGI et al

Serial No.: 10/630,444

Filed:

For:

July 29, 2003

METHOD FOR MANUFACTURING SEMICONDUCTOR DEVICE

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUBMISSION

Sir:

Submitted herewith is a copy of art cited in a communication from a foreign patent office in a counterpart foreign application, together with a form listing the same for the convenience of the Examiner. A translation of relevant parts of the Office Action has been provided in lieu of a Statement of Relevancy of the present invention to the teachings of the teachings of the cited prior art.

I certify that each item of information contained in this Submission was cited in a communication from a foreign patent office in connection with a corresponding patent application not more than three months prior to the filing of this Submission.

I respectfully request that the information submitted be considered and enclose our check number 24933 in payment of the required \$180.00 fee.

In the event the actual fee is greater than the payment submitted or is inadvertently not enclosed or if any additional fee due during the pendency of this application is not paid, the patent and Trademark Office is authorized to charge the underpayment to Deposit Account No. 15-0700.

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents P.O. Box 1450, Alexandria, VA 22313-1450, on June 20, 2006 Max Moskowitz

Name of applicant, assignee or Registered Representative

Signature June 20, 2006 Date of Signature

Respectfully submitted,

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| | | | | Application | 10/630,444 | OFGS File No. P/3236-39 | | | | |
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| APPLIC | CANT | S ART CITATIO | Kenichi KOYARAGI | d. | | | | | | |
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